

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/630,922	<b>Applicant(s)/Patent under Reexamination</b> LEE ET AL.
	<b>Examiner</b> NABIL Z. HINDI	<b>Art Unit</b> 2627

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
369	53.21	7/24/06	ABJ
	53.15	7/24/06	ABJ